Search Notes



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Applicant(s)/Patent Under Reexamination

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YAMAUCHI ET AL.

Examiner

Art Unit

Lee, John W

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SEARCHED

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Class	Subclass	Date	Examiner
382	166	05/18/2005	John W. Lee

SEARCH NOTES

Search Notes	Date	Examiner
Inventor Search	05/18/2007	John W. Lee
EAST Search	05/18/2007	John W. Lee

INTERFERENCE SEARCH

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